

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/660,605 EZAKI ET AL.	
		Examiner Son T. Dinh	Art Unit 2824	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0052899 A1	03-2005	Hatake, Hitoshi	365/154
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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